

Search Notes

Application/Control No.

10/605,983

Examiner

Phallaka Kik

Applicant(s)/Patent under
Reexamination

BUFFET ET AL.

Art Unit

2825

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------------|----------|
| 716 | 5,7 | 10/26/2005 | PK |
| 703 | 2, 14 | 10/26/2005 | PK |
| 702 | 118 | 10/26/2005 | PK |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-----------------------------|----------|------------|----------|
| 716 | 5,7 | 10/26/2005 | PK |
| 703 | 2,14 | 10/26/2005 | PK |
| 702 | 118 | 10/26/2005 | PK |
| --USPGPUB (see attached) | | 10/26/2005 | PK |

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|-------------------------------------------------------------------------------------------------------------------------------------------|------------|------|
| BRS (EAST) --USPAT, USPGPUB Cls/Sub searched: 716/1-21; 324/318; 333/219; 336/200, 182; 227/E27.046; 702/118(see attached) | 10/26/2005 | PK |
| BRS (EAST) --USPAT, USPGPUB (con't) Cls/Sub searched: 703/2,14-16 (see attached) | 10/26/2005 | PK |
| --EPO, JPO, IBM TDB, Derwent (see attached) | 10/26/2005 | PK |
| IEE/IEEE Xplore (see attached) | 10/26/2005 | |
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